INTEGRATED CIRCUITS

DATA SHEET

74F1244 Octal buffer (3-State)

Product specification

1989 Apr 04

IC15 Data Handbook





Octal buffer (3-State)

74F1244

FEATURES

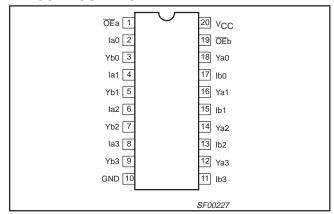
- High impedance NPN base inputs for reduced loading (20μA in High and Low states)
- Low power, light loading
- Functional pin-for-pin equivalent of 74F244
- 1/30th the bus loading of 74F244
- Provides ideal interface and increase fan-out of MOS microprocessors
- Octal bus interface
- 3-State buffer outputs sink 64mA and source 15mA

DESCRIPTION

The 74F1244 is an octal buffer that is ideal for driving bus lines or buffer memory address registers. The outputs are capable of sinking 64mA and sourcing up to 15mA, producing very good capacitive drive characteristics. The device features two Output Enables, $\overline{\text{OE}}$ a and $\overline{\text{OE}}$ b, each controlling four of the 3-State outputs.

The 74F1244 is pin and functionally compatible with the 74F244. The lower power and light bus loading features make it an ideal part to interface directly with MOS microprocessors.

PIN CONFIGURATION



TYPE	TYPICAL PROPAGATION DELAY	TYPICAL SUPPLY CURRENT (TOTAL)
74F1244	4.5ns	43mA

ORDERING INFORMATION

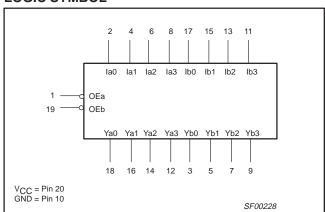
DESCRIPTION	COMMERCIAL RANGE V_{CC} = 5V $\pm 10\%$, T_{amb} = 0°C to +70°C	DRAWING NUMBER
20-pin plastic DIP	N74F1244N	SOT146-1
20-pin plastic SOL	N74F1244D	SOT163-1

INPUT AND OUTPUT LOADING AND FAN OUT TABLE

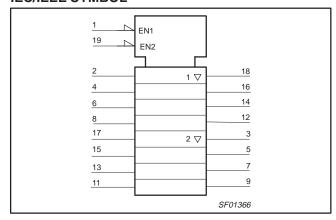
PINS	DESCRIPTION	74F (U.L.) HIGH/LOW	LOAD VALUE HIGH/LOW
lan, Ibn	Data inputs	1.0/0.033	20μΑ/20μΑ
ŌEa, ŌEb	Output enable inputs (active Low)	1.0/0.033	20μΑ/20μΑ
Yan, Ybn	Data outputs	750/106.7	15mA/64mA

NOTE: One (1.0) FAST unit load is defined as: 20µA in the high state and 0.6mA in the low state.

LOGIC SYMBOL



IEC/IEEE SYMBOL

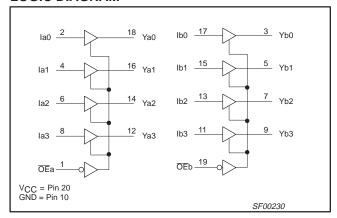


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LOGIC DIAGRAM



FUNCTION TABLE

	INP	UTS		OUTPUTS				
OE a	la	OE b	lb	Ya	Yb			
L	L	L	L	L	L			
L	Н	L	Н	Н	Н			
Н	Х	Н	Х	Z	Z			

High voltage levelLow voltage level

X = Don't care Z = High impedance "off" state

ABSOLUTE MAXIMUM RATINGS

(Operation beyond the limit set forth in this table may impair the useful life of the device. Unless otherwise noted these limits are over the operating free-air temperature range.)

SYMBOL	PARAMETER	RATING	UNIT
V _{CC}	Supply voltage	-0.5 to +7.0	V
V _{IN}	Input voltage	-0.5 to +7.0	V
I _{IN}	Input current	-30 to +5	mA
V _{OUT}	Voltage applied to output in High output state	−0.5 to V _{CC}	V
I _{OUT}	Current applied to output in Low output state	128	mA
T _{amb}	Operating free-air temperature range	0 to +70	°C
T _{stg}	Storage temperature range	-65 to +150	°C

RECOMMENDED OPERATING CONDITIONS

CVMDOL	DADAMETED	LIMITS							
SYMBOL	PARAMETER	MIN	NOM	MAX	UNIT				
V _{CC}	Supply voltage	4.5	5.0	5.5	V				
V _{IH}	High-level input voltage	2.0			V				
V _{IL}	Low-level input voltage			0.8	V				
I _{IK}	Input clamp current			-18	mA				
I _{OH}	High-level output current			-15	mA				
I _{OL}	Low-level output current			64	mA				
T _{amb}	Operating free-air temperature range	0		+70	°C				

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DC ELECTRICAL CHARACTERISTICS

(Over recommended operating free-air temperature range unless otherwise noted.)

CVMDOL	DADAMETED		ST CONDITIONS	21		LIMITS		UNIT
SYMBOL	PARAMETER	15	ST CONDITIONS	MIN	TYP ²	MAX	UNII	
			±10% V _{CC}	2.5			V	
\ \ \	Lligh lavel output valtage	$V_{CC} = MIN,$ $V_{IL} = MAX,$	$I_{OH} = -3mA$	±5% V _{CC}	2.7	3.4		V
V _{OH}	High-level output voltage	$V_{IH} = MIN$	1 - 15mA	±10% V _{CC}	2.0			V
			$I_{OH} = -15 \text{mA}$	±5% V _{CC}	2.0			V
V	Low level output voltage	$V_{CC} = MIN,$ $V_{II} = MAX,$	I _{OL} = 48mA	±10% V _{CC}		0.38	0.55	V
V _{OL}	Low-level output voltage	$V_{IH} = MIN$	I _{OL} = 64mA	±5% V _{CC}		0.42	0.55	V
V _{IK}	Input clamp voltage	V _{CC} = MIN, I _I	= I _{IK}		-0.73	-1.2	V	
II	Input current at maximum input voltage	$V_{CC} = 0.0V, V$	' _I = 7.0V			100	μΑ	
I _{IH}	High-level input current	V _{CC} = MAX, \			20	μΑ		
I _{IL}	Low-level input current	V _{CC} = MAX, \			-20	μΑ		
I _{OZH}	Off-state output current, High-level voltage applied	$V_{CC} = MAX, V_O = 2.7V$					50	μΑ
I _{OZL}	Off-state output current, Low-level voltage applied	V _{CC} = MAX, \			-50	μА		
I _{OS}	Short-circuit output current ³	$V_{CC} = MAX$	-100		-225	mA		
	Іссн				30	40	mA	
I _{CC}	Supply current (total) I _{CCL}	$V_{CC} = MAX$		57	75	mA		
	Iccz					43	58	mA

NOTES:

AC ELECTRICAL CHARACTERISTICS

				LIMITS							
SYMBOL	PARAMETER	TEST CONDITION	V.	_{mb} = +25 _{CC} = +5.0 0pF, R _L =	V	T _{amb} = 0°C V _{CC} = +5. C _L = 50pF,	UNIT				
			MIN	TYP	MAX	MIN	MAX				
t _{PLH} t _{PHL}	Propagation delay Ian, Ibn to Yn	Waveform 1	2.5 2.0	4.0 5.0	5.5 7.0	2.5 2.0	6.0 7.5	ns ns			
t _{PZH}	Output Enable time to High or Low level	Waveform 2 Waveform 3	3.0 3.0	6.0 6.5	7.5 8.0	3.0 3.0	8.5 8.5	ns ns			
t _{PHZ} t _{PLZ}	Output Disable time to High or Low level	Waveform 2 Waveform 3	2.0 2.0	4.0 4.0	5.5 5.5	2.0 2.0	6.0 6.0	ns ns			

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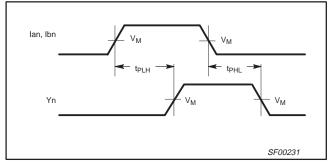
For conditions shown as MIN or MAX, use the appropriate value specified under recommended operating conditions for the applicable type.
All typical values are at V_{CC} = 5V, T_{amb} = 25°C.
Not more than one output should be shorted at a time. For testing I_{OS}, the use of high-speed test apparatus and/or sample-and-hold techniques are preferable in order to minimize internal heating and more accurately reflect operational values. Otherwise, prolonged shorting of a High output may raise the chip temperature well above normal and thereby cause invalid readings in other parameter tests. In any sequence of parameter tests, IOS tests should be performed last.

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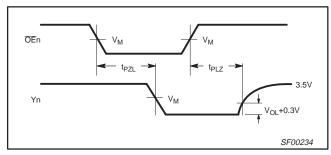
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AC WAVEFORMS

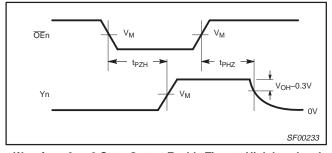
For all waveforms, $V_M = 1.5V$.



Waveform 1. For Non-Inverting Outputs

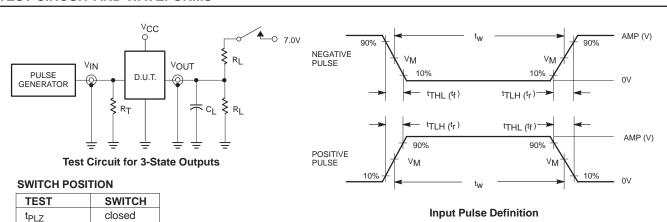


Waveform 3. 3-State Output enable Time to Low Level and Output Disable Time from Low Level



Waveform 2. 3-State Output Enable Time to High Level and Output Disable Time from High Level

TEST CIRCUIT AND WAVEFORMS



DEFINITIONS:

t_{PZL} All other

 R_L = Load resistor;

see AC electrical characteristics for value.

closed

open

C_L = Load capacitance includes jig and probe capacitance; see AC electrical characteristics for value.

 R_T = Termination resistance should be equal to Z_{OUT} of pulse generators.

family	INP	INPUT PULSE REQUIREMENTS												
	amplitude	V_{M}	rep. rate	t _w	t _{TLH}	t _{THL}								
74F	74F 3.0V		1MHz	500ns	2.5ns	2.5ns								

SF00777

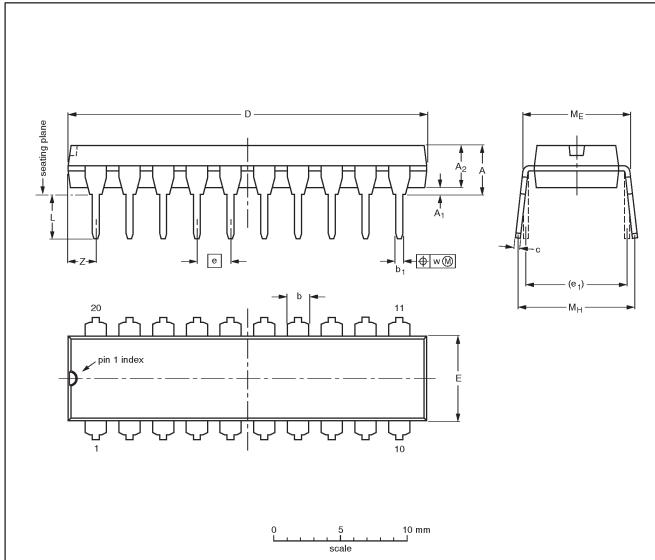
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DIP20: plastic dual in-line package; 20 leads (300 mil)

SOT146-1



DIMENSIONS (inch dimensions are derived from the original mm dimensions)

UNIT	A max.	A ₁ min.	A ₂ max.	b	b ₁	С	D ⁽¹⁾	E ⁽¹⁾	е	e ₁	L	ME	M _H	w	Z ⁽¹⁾ max.
mm	4.2	0.51	3.2	1.73 1.30	0.53 0.38	0.36 0.23	26.92 26.54	6.40 6.22	2.54	7.62	3.60 3.05	8.25 7.80	10.0 8.3	0.254	2.0
inches	0.17	0.020	0.13	0.068 0.051	0.021 0.015	0.014 0.009	1.060 1.045	0.25 0.24	0.10	0.30	0.14 0.12	0.32 0.31	0.39 0.33	0.01	0.078

Note

1. Plastic or metal protrusions of 0.25 mm maximum per side are not included.

OUTLINE		EUROPEAN	ISSUE DATE			
VERSION	IEC	JEDEC	EIAJ		PROJECTION	ISSUE DATE
SOT146-1			SC603			92-11-17 95-05-24

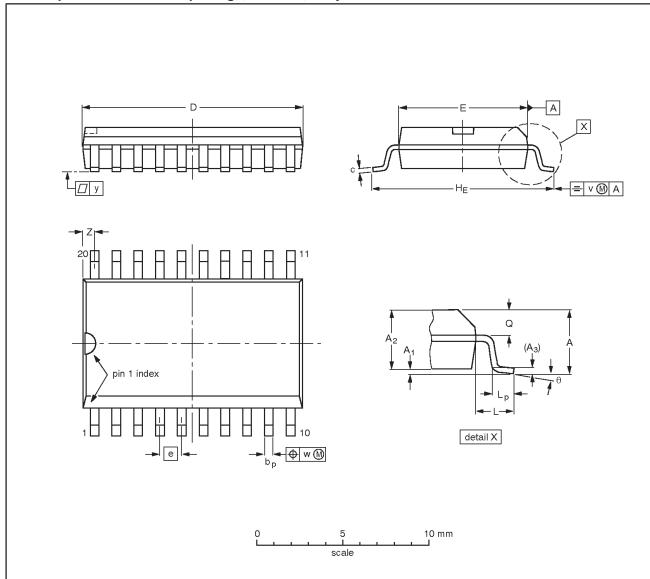
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SO20: plastic small outline package; 20 leads; body width 7.5 mm

SOT163-1



DIMENSIONS (inch dimensions are derived from the original mm dimensions)

UNIT	A max.	A ₁	A ₂	A ₃	bр	С	D ⁽¹⁾	E ⁽¹⁾	е	HE	L	Lp	Q	v	w	у	z ⁽¹⁾	θ
mm	2.65	0.30 0.10	2.45 2.25	0.25	0.49 0.36	0.32 0.23	13.0 12.6	7.6 7.4	1.27	10.65 10.00	1.4	1.1 0.4	1.1 1.0	0.25	0.25	0.1	0.9 0.4	8°
inches	0.10	0.012 0.004	0.096 0.089	0.01	0.019 0.014	0.013 0.009	0.51 0.49	0.30 0.29	0.050	0.419 0.394	0.055	0.043 0.016		0.01	0.01	0.004	0.035 0.016	0°

Note

1. Plastic or metal protrusions of 0.15 mm maximum per side are not included.

OUTLINE		REFERENCES		EUROPEAN	ISSUE DATE	
VERSION	IEC	JEDEC	EIAJ		PROJECTION	ISSUE DATE
SOT163-1	075E04	MS-013AC				-95-01-24 97-05-22

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Data sheet status

Data sheet status	Product status	Definition [1]
Objective specification	Development	This data sheet contains the design target or goal specifications for product development. Specification may change in any manner without notice.
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Product specification	Production	This data sheet contains final specifications. Philips Semiconductors reserves the right to make changes at any time without notice in order to improve design and supply the best possible product.

^[1] Please consult the most recently issued datasheet before initiating or completing a design.

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